



# ISP1105/1106

Advanced USB transceivers

Rev. 10 — 28 September 2009

Product data sheet

## 1. General description

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The ISP1105/1106 range of Universal Serial Bus (USB) transceivers are compliant with the *Universal Serial Bus Specification Rev. 2.0*. They can transmit and receive serial data at both full-speed (12 Mbit/s) and low-speed (1.5 Mbit/s) data rates. The ISP1105/1106 range can be used as a USB device transceiver or a USB host transceiver.

They allow USB Application Specific ICs (ASICs) and Programmable Logic Devices (PLDs) with power supply voltages from 1.65 V to 3.6 V to interface with the physical layer of the Universal Serial Bus. They have an integrated 5 V-to-3.3 V voltage regulator for direct powering via the USB supply  $V_{BUS}$ .

ISP1105 allows single-ended and differential input modes selectable by a MODE input and it is available in HVQFN16 and HBCC16 packages. ISP1106 allows only differential input mode and is available in both TSSOP16 and HBCC16 packages.

The ISP1105/1106 are ideal for portable electronics devices such as mobile phones, digital still cameras, Personal Digital Assistants (PDA) and Information Appliances (IA).

## 2. Features

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- Complies with *Universal Serial Bus Specification Rev. 2.0*
- Can transmit and receive serial data at both full-speed (12 Mbit/s) and low-speed (1.5 Mbit/s) data rates
- Integrated bypassable 5 V-to-3.3 V voltage regulator for powering via USB  $V_{BUS}$
- $V_{BUS}$  disconnection indication through VP and VM
- Used as a USB device transceiver or a USB host transceiver
- Stable RCV output during SE0 condition
- Two single-ended receivers with hysteresis
- Low-power operation
- Supports an I/O voltage range from 1.65 V to 3.6 V
- $\pm 12$  kV ESD protection at the D+, D-,  $V_{CC(5.0)}$  and GND pins
- Full industrial operating temperature range from  $-40$  °C to  $+85$  °C
- Available in small HBCC16, HVQFN16 (only ISP1105) and TSSOP16 (only ISP1106) packages

The ISP1105 HBCC16 and HVQFN16 are lead-free and halogen-free.

The ISP1106 HBCC16 is lead-free.

### 3. Applications

- Portable electronic devices, such as:
  - ◆ Mobile phone
  - ◆ Digital still camera
  - ◆ Personal Digital Assistant (PDA)
  - ◆ Information Appliance (IA).

### 4. Ordering information

**Table 1. Ordering information**

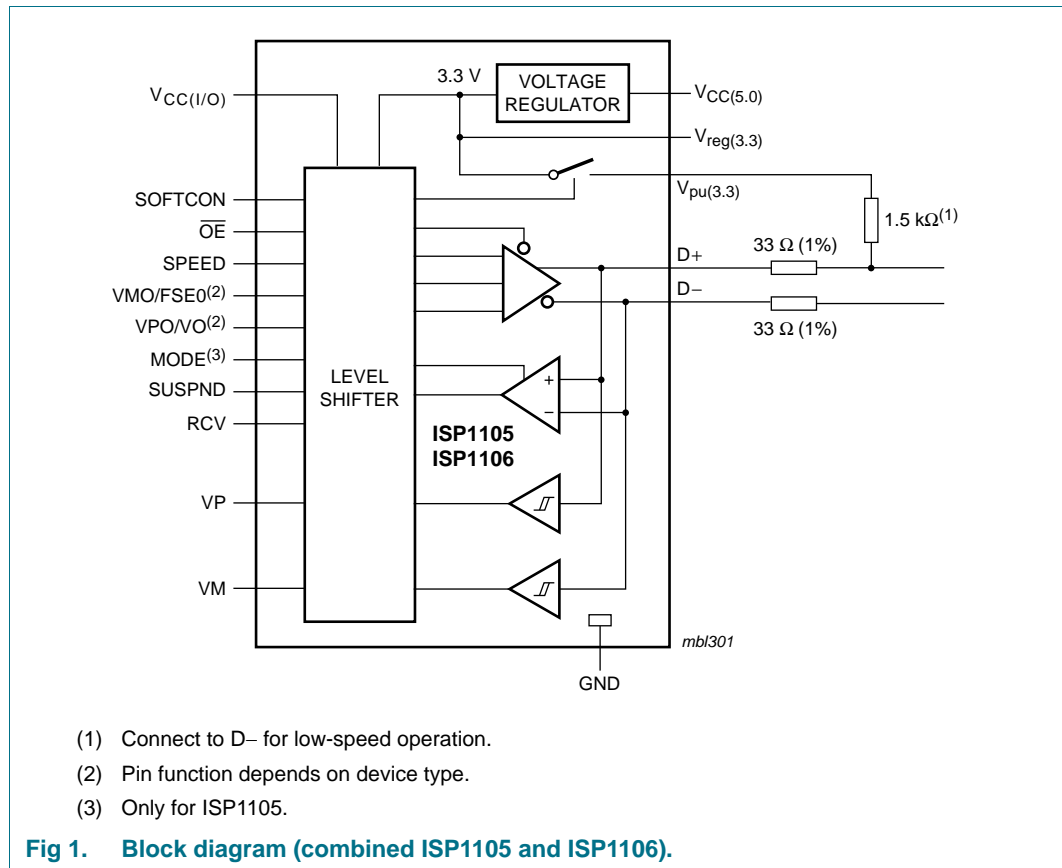
Commercial product code	Package description	Packing	Minimum sellable quantity
ISP1105BSTM	HVQFN16; 16 terminals; body 3 × 3 × 0.85 mm	13 inch tape and reel non-dry pack	6000 pieces
ISP1105WTS	HBCC16; 16 terminals; body 3 × 3 × 0.65 mm	7 inch tape and reel non-dry pack	1400 pieces
ISP1105WTM	HBCC16; 16 terminals; body 3 × 3 × 0.65 mm	13 inch tape and reel non-dry pack	6000 pieces
ISP1106WTS	HBCC16; 16 terminals; body 3 × 3 × 0.65 mm	7 inch tape and reel non-dry pack	1400 pieces
ISP1106DHTM	TSSOP16; 16 leads; body width 4.4 mm	13 inch tape and reel non-dry pack	2500 pieces

#### 4.1 Ordering options

**Table 2. Selection guide**

Product	Package	Description
ISP1105	HVQFN16 and HBCC16	supports both single-ended and differential input modes; see <a href="#">Table 5</a> and <a href="#">Table 6</a> .
ISP1106	TSSOP16 and HBCC16	supports only the differential input mode; see <a href="#">Table 6</a> .

## 5. Block diagram



## 6. Pinning information

### 6.1 Pinning

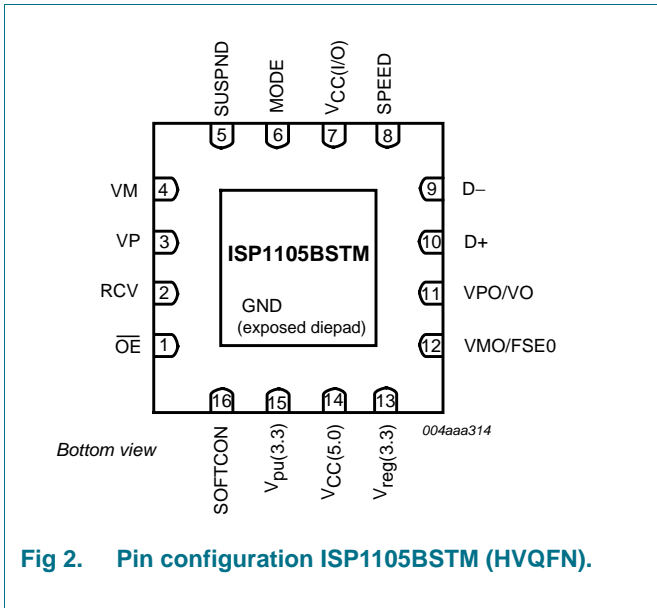


Fig 2. Pin configuration ISP1105BSTM (HVQFN).

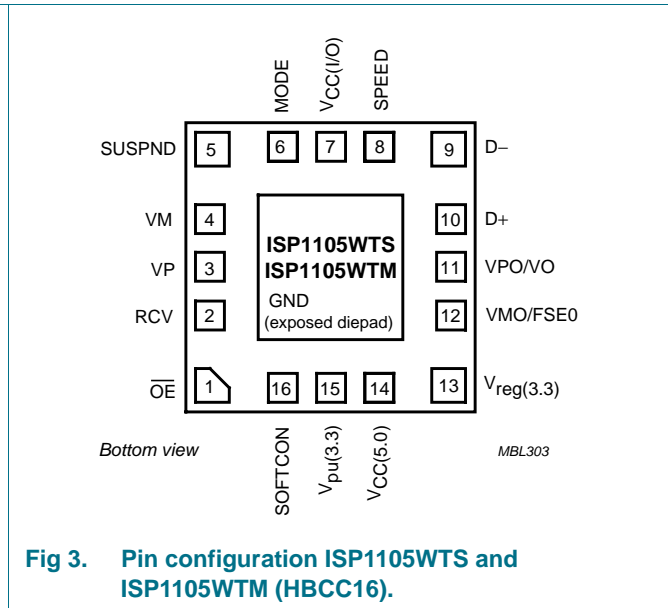


Fig 3. Pin configuration ISP1105WTS and ISP1105WTM (HBCC16).

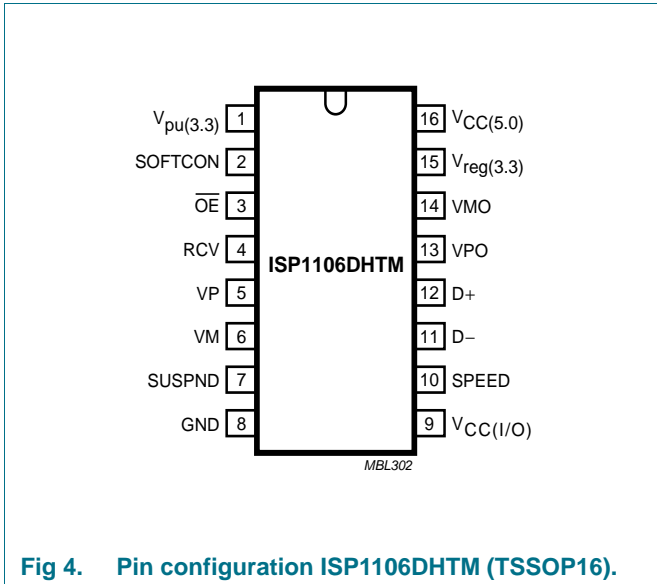


Fig 4. Pin configuration ISP1106DHTM (TSSOP16).

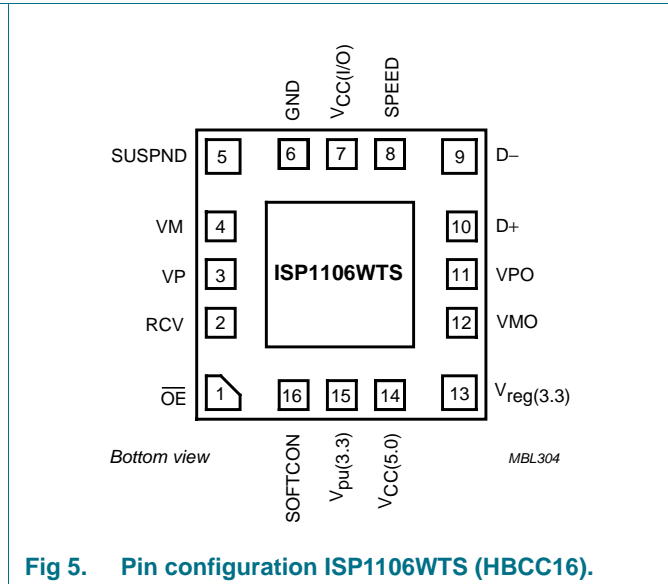


Fig 5. Pin configuration ISP1106WTS (HBCC16).

### 6.2 Pin description

**Table 3. Pin description**

Symbol <sup>[1]</sup>	Pin				Type	Description
	ISP1105		ISP1106			
	BSTM	WTS, WTM	DHTM	WTS		
$\overline{OE}$	1	1	3	1	I	output enable input (CMOS level with respect to $V_{CC(I/O)}$ , active LOW); enables the transceiver to transmit data on the USB bus input pad; push pull; CMOS
RCV	2	2	4	2	O	differential data receiver output (CMOS level with respect to $V_{CC(I/O)}$ ); driven LOW when input SUSPND is HIGH; the output state of RCV is preserved and stable during an SE0 condition output pad; push pull; 4 mA output drive; CMOS
VP	3	3	5	3	O	single-ended D+ receiver output (CMOS level with respect to $V_{CC(I/O)}$ ); for external detection of single-ended zero (SE0), error conditions, speed of connected device; driven HIGH when no supply voltage is connected to $V_{CC(5.0)}$ and $V_{reg(3.3)}$ output pad; push pull; 4 mA output drive; CMOS
VM	4	4	6	4	O	single-ended D– receiver output (CMOS level with respect to $V_{CC(I/O)}$ ); for external detection of single-ended zero (SE0), error conditions, speed of connected device; driven HIGH when no supply voltage is connected to $V_{CC(5.0)}$ and $V_{reg(3.3)}$ output pad; push pull; 4 mA output drive; CMOS
SUSPND	5	5	7	5	I	suspend input (CMOS level with respect to $V_{CC(I/O)}$ ); a HIGH level enables low-power state while the USB bus is inactive and drives output RCV to a LOW level input pad; push pull; CMOS
MODE	6	6	-	-	I	mode input (CMOS level with respect to $V_{CC(I/O)}$ ); a HIGH level enables the differential input mode (VPO, VMO) whereas a LOW level enables a single-ended input mode (VO, FSE0); see <a href="#">Table 5</a> and <a href="#">Table 6</a> input pad; push pull; CMOS
GND	die pad	die pad	8	6	-	ground supply <sup>[2]</sup>
$V_{CC(I/O)}$	7	7	9	7	-	supply voltage for digital I/O pins (1.65 V to 3.6 V). When $V_{CC(I/O)}$ is not connected, the (D+, D–) pins are in three-state; this supply pin is totally independent of $V_{CC(5.0)}$ and $V_{reg(3.3)}$ and must never exceed the $V_{reg(3.3)}$ voltage
SPEED	8	8	10	8	I	speed selection input (CMOS level with respect to $V_{CC(I/O)}$ ); adjusts the slew rate of differential data outputs D+ and D– according to the transmission speed <b>LOW</b> — low-speed (1.5 Mbit/s) <b>HIGH</b> — full-speed (12 Mbit/s) input pad; push pull; CMOS
D–	9	9	11	9	A/I/O	negative USB data bus connection (analog, differential); for low-speed mode connect to pin $V_{pu(3.3)}$ via a 1.5 k $\Omega$ resistor
D+	10	10	12	10	A/I/O	positive USB data bus connection (analog, differential); for full-speed mode connect to pin $V_{pu(3.3)}$ via a 1.5 k $\Omega$ resistor

**Table 3. Pin description ...continued**

Symbol <sup>[1]</sup>	Pin				Type	Description
	ISP1105		ISP1106			
	BSTM	WTS, WTM	DHTM	WTS		
VPO/VO	11	11	-	-	I	driver data input (CMOS level with respect to $V_{CC(I/O)}$ , Schmitt trigger); see <a href="#">Table 5</a> and <a href="#">Table 6</a>
VPO	-	-	13	11		input pad; push pull; CMOS
VO	-	-	-	-		
VMO/FSE0	12	12	-	-	I	driver data input (CMOS level with respect to $V_{CC(I/O)}$ , Schmitt trigger); see <a href="#">Table 5</a> and <a href="#">Table 6</a>
VMO	-	-	14	12		input pad; push pull; CMOS
FSE0	-	-	-	-		
$V_{reg(3.3)}$	13	13	15	13	-	<p><b>internal regulator option:</b> regulated supply voltage output (3.0 V to 3.6 V) during 5 V operation; a decoupling capacitor of at least 0.1 <math>\mu</math>F is required</p> <p><b>regulator bypass option:</b> used as a supply voltage input for 3.3 V <math>\pm</math> 10 % operation</p>
$V_{CC(5.0)}$	14	14	16	14	-	<p><b>internal regulator option:</b> supply voltage input (4.0 V to 5.5 V); can be connected directly to USB supply <math>V_{BUS}</math></p> <p><b>regulator bypass option:</b> connect to <math>V_{reg(3.3)}</math></p>
$V_{pu(3.3)}$	15	15	1	15	-	<p>pull-up supply voltage (3.3 V <math>\pm</math> 10 %); connect an external 1.5 k<math>\Omega</math> resistor on D+ (full-speed) or D- (low-speed); pin function is controlled by input SOFTCON</p> <p><b>SOFTCON = LOW</b> — <math>V_{pu(3.3)}</math> floating (high impedance); ensures zero pull-up current</p> <p><b>SOFTCON = HIGH</b> — <math>V_{pu(3.3)} = 3.3</math> V; internally connected to <math>V_{reg(3.3)}</math></p>
SOFTCON	16	16	2	16	I	<p>software controlled USB connection input; a HIGH level applies 3.3 V to pin <math>V_{pu(3.3)}</math>, which is connected to an external 1.5 k<math>\Omega</math> pull-up resistor; this allows USB connect/disconnect signalling to be controlled by software</p> <p>input pad; push pull; CMOS</p>

[1] Symbol names with an overscore (e.g.  $\overline{NAME}$ ) indicate active LOW signals.

[2] ISP1105: ground terminal is connected to the exposed die pad (heat sink).

## 7. Functional description

### 7.1 Function selection

**Table 4. Function table**

SUSPND	$\overline{\text{OE}}$	(D+, D-)	RCV	VP/VM	Function
L	L	driving and receiving	active	active	normal driving (differential receiver active)
L	H	receiving <sup>[1]</sup>	active	active	receiving
H	L	driving	inactive <sup>[2]</sup>	active	driving during 'suspend' <sup>[3]</sup> (differential receiver inactive)
H	H	high-Z <sup>[1]</sup>	inactive <sup>[2]</sup>	active	low-power state

[1] Signal levels on (D+, D-) are determined by other USB devices and external pull-up/down resistors.

[2] In 'suspend' mode (SUSPND = HIGH) the differential receiver is inactive and output RCV is always LOW. Out-of-suspend ('K') signalling is detected via the single-ended receivers VP and VM.

[3] During suspend, the slew-rate control circuit of low-speed operation is disabled. The (D+, D-) lines are still driven to their intended states, without slew-rate control. This is permitted because driving during suspend is used to signal remote wake-up by driving a 'K' signal (one transition from idle to 'K' state) for a period of 1 to 15 ms.

### 7.2 Operating functions

**Table 5. Driving function (pin  $\overline{\text{OE}} = \text{L}$ ) using single-ended input data interface for ISP1105 (pin MODE = L)**

FSE0	VO	Data
L	L	differential logic 0
L	H	differential logic 1
H	L	SE0
H	H	SE0

**Table 6. Driving function (pin  $\overline{\text{OE}} = \text{L}$ ) using differential input data interface for ISP1105 (pin MODE = H) and ISP1106**

VMO	VPO	Data
L	L	SE0
L	H	differential logic 1
H	L	differential logic 0
H	H	illegal state

**Table 7. Receiving function (pin  $\overline{\text{OE}} = \text{H}$ )**

(D+, D-)	RCV	VP <sup>[1]</sup>	VM <sup>[1]</sup>
Differential logic 0	L	L	H
Differential logic 1	H	H	L
SE0	RCV* <sup>[2]</sup>	L	L

[1] VP = VM = H indicates the sharing mode ( $V_{CC(5.0)}$  and  $V_{reg(3.3)}$  are disconnected).

[2] RCV\* denotes the signal level on output RCV just before SE0 state occurs. This level is stable during the SE0 period.

### 7.3 Power supply configurations

The ISP1105/1106 can be used with different power supply configurations, which can be changed dynamically. An overview is given in [Table 9](#).

**Normal mode** — Both  $V_{CC(I/O)}$  and  $V_{CC(5.0)}$  or ( $V_{CC(5.0)}$  and  $V_{reg(3.3)}$ ) are connected. For 5 V operation,  $V_{CC(5.0)}$  is connected to a 5 V source (4.0 V to 5.5 V). The internal voltage regulator then produces 3.3 V for the USB connections. For 3.3 V operation, both  $V_{CC(5.0)}$  and  $V_{reg(3.3)}$  are connected to a 3.3 V source (3.0 V to 3.6 V).  $V_{CC(I/O)}$  is independently connected to a voltage source (1.65 V to 3.6 V), depending on the supply voltage of the external circuit.

**Disable mode** —  $V_{CC(I/O)}$  is not connected,  $V_{CC(5.0)}$  or ( $V_{CC(5.0)}$  and  $V_{reg(3.3)}$ ) are connected. In this mode, the internal circuits of the ISP1105/1106 ensure that the (D+, D-) pins are in three-state and the power consumption drops to the low-power (suspended) state level. Some hysteresis is built into the detection of  $V_{CC(I/O)}$  lost.

**Sharing mode** —  $V_{CC(I/O)}$  is connected, ( $V_{CC(5.0)}$  and  $V_{reg(3.3)}$ ) are not connected. In this mode, the (D+, D-) pins are made three-state and the ISP1105/1106 allows external signals of up to 3.6 V to share the (D+, D-) lines. The internal circuits of the ISP1105/1106 ensure that virtually no current (maximum 10  $\mu$ A) is drawn via the (D+, D-) lines. The power consumption through pin  $V_{CC(I/O)}$  drops to the low-power (suspended) state level. Both the VP and VM pins are driven HIGH to indicate this mode. Pin RCV is made LOW. Some hysteresis is built into the detection of  $V_{reg(3.3)}$  lost.

**Table 8. Pin states in disable or sharing mode**

Pins	Disable mode state	Sharing mode state
$V_{CC(5.0)}$ / $V_{reg(3.3)}$	5 V input / 3.3 V output; 3.3 V input / 3.3 V input	not present
$V_{CC(I/O)}$	not present	1.65 V to 3.6 V input
$V_{pu(3.3)}$	high impedance (off)	high impedance (off)
(D+, D-)	high impedance	high impedance
(VP, VM)	invalid <sup>[1]</sup>	H
RCV	invalid <sup>[1]</sup>	L
Inputs (VO/VPO, FSE0/VMO, SPEED, MODE <sup>[2]</sup> , SUSPND, OE, SOFTCON)	high impedance	high impedance

[1] High impedance or driven LOW.

[2] ISP1105 only.

**Table 9. Power supply configuration overview**

$V_{CC(5.0)}$ or $V_{reg(3.3)}$	$V_{CC(I/O)}$	Configuration	Special characteristics
Connected	connected	normal mode	-
Connected	not connected	disable mode	(D+, D-) and $V_{pu(3.3)}$ high impedance; VP, VM, RCV: invalid <sup>[1]</sup>
Not connected	connected	sharing mode	(D+, D-) and $V_{pu(3.3)}$ high impedance; VP, VM driven HIGH; RCV driven LOW

[1] High impedance or driven LOW.



### 7.4 Power supply input options

The ISP1105/1106 range has two power supply input options.

**Internal regulator** —  $V_{CC(5.0)}$  is connected to 4.0 V to 5.5 V. The internal regulator is used to supply the internal circuitry with 3.3 V (nominal). The  $V_{reg(3.3)}$  pin becomes a 3.3 V output reference.

**Regulator bypass** —  $V_{CC(5.0)}$  and  $V_{reg(3.3)}$  are connected to the same supply. The internal regulator is bypassed and the internal circuitry is supplied directly from the  $V_{reg(3.3)}$  power supply. The voltage range is 3.0 V to 3.6 V to comply with the USB specification.

The supply voltage range for each input option is specified in [Table 10](#).

**Table 10. Power supply input options**

Input option	$V_{CC(5.0)}$	$V_{reg(3.3)}$	$V_{CC(I/O)}$
Internal regulator	supply input for internal regulator (4.0 V to 5.5 V)	voltage reference output (3.3 V, 300 $\mu$ A)	supply input for digital I/O pins (1.65 V to 3.6 V)
Regulator bypass	connected to $V_{reg(3.3)}$ with maximum voltage drop of 0.3 V (2.7 V to 3.6 V)	supply input (3.0 V to 3.6 V)	supply input for digital I/O pins (1.65 V to 3.6 V)

## 8. Electrostatic discharge (ESD)

### 8.1 ESD protection

The pins that are connected to the USB connector (D+, D-,  $V_{CC(5.0)}$  and GND) have a minimum of  $\pm 12$  kV ESD protection. The  $\pm 12$  kV measurement is limited by the test equipment. Capacitors of  $4.7 \mu\text{F}$  connected from  $V_{\text{reg}(3.3)}$  to GND and  $V_{CC(5.0)}$  to GND are required to achieve this  $\pm 12$  kV ESD protection (see [Figure 6](#)).

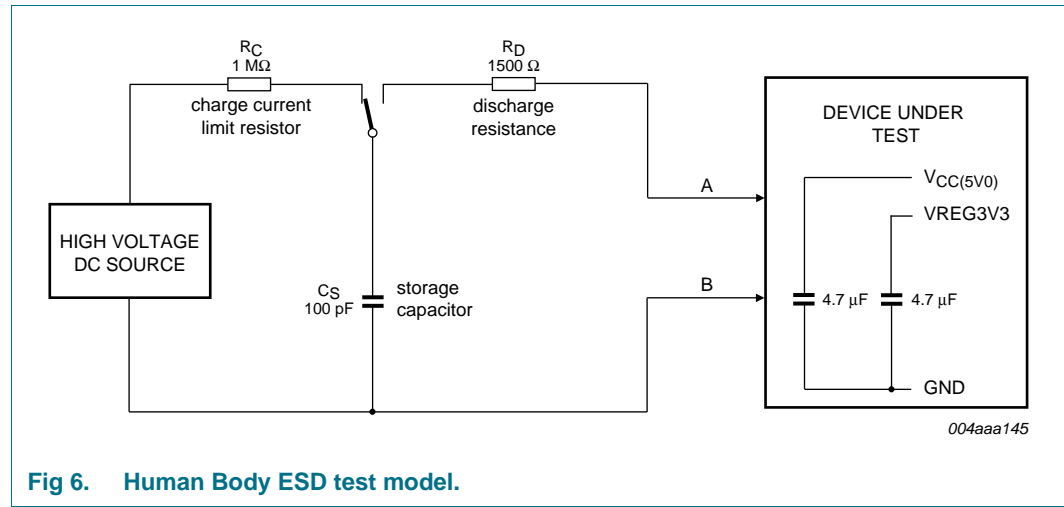


Fig 6. Human Body ESD test model.

### 8.2 ESD test conditions

A detailed report on test set-up and results is available on request.

## 9. Limiting values

**Table 11. Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{CC(5.0)}$	supply voltage		-0.5	+6.0	V
$V_{CC(I/O)}$	I/O supply voltage		-0.5	+4.6	V
$V_{reg(3.3)}$	regulated supply voltage		-0.5	+4.6	V
$V_I$	DC input voltage		-0.5	$V_{CC(I/O)} + 0.5$	V
$I_{lu}$	latch-up current	$V_I = -1.8\text{ V to }5.4\text{ V}$	-	100	mA
$V_{esd}$	electrostatic discharge voltage	$I_{LI} < 1\ \mu\text{A}$ <a href="#">[1][2]</a>			
		on pins D+, D-, $V_{CC(5.0)}$ and GND	-12000	+12000	V
		on other pins	-2000	+2000	V
$T_{stg}$	storage temperature		-40	+125	°C

[1] Testing equipment limits measurement to only  $\pm 12\text{ kV}$ . Capacitors needed on  $V_{CC(5.0)}$  and  $V_{reg(3.3)}$ ; see [Section 8](#).

[2] Equivalent to discharging a 100 pF capacitor via a 1.5 k $\Omega$  resistor (Human Body Model).

## 10. Recommended operating conditions

**Table 12. Recommended operating conditions**

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{CC(5.0)}$	supply voltage (internal regulator option)	5 V operation	4.0	5.0	5.5	V
$V_{reg(3.3)}$	supply voltage (regulator bypass option)	3.3 V operation	3.0	3.3	3.6	V
$V_{CC(I/O)}$	I/O supply voltage		1.65	-	3.6	V
$V_I$	input voltage		0	-	$V_{CC(I/O)}$	V
$V_{I(AI/O)}$	input voltage on analog I/O pins (D+/D-)		0	-	3.6	V
$T_{amb}$	operating ambient temperature		-40	-	+85	°C

### 11. Static characteristics

**Table 13. Static characteristics: supply pins**

$V_{CC} = 4.0\text{ V to }5.5\text{ V}$  or  $V_{reg(3.3)} = 3.0\text{ V to }3.6\text{ V}$ ;  $V_{CC(I/O)} = 1.65\text{ V to }3.6\text{ V}$ ;  $V_{GND} = 0\text{ V}$ ; see [Table 10](#) for valid voltage level combinations;  $T_{amb} = -40\text{ °C to }+85\text{ °C}$ ; unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{reg(3.3)}$	regulated supply voltage output	internal regulator option; $I_{load} \leq 300\ \mu\text{A}$	[1][2] 3.0	3.3	3.6	V
$I_{CC}$	operating supply current	full-speed transmitting and receiving at 12 Mbit/s; $C_L = 50\text{ pF}$ on D+/D-	[3] -	4	8	mA
$I_{CC(I/O)}$	operating I/O supply current	full-speed transmitting and receiving at 12 Mbit/s	[3] -	1	2	mA
$I_{CC(idle)}$	supply current during full-speed idle and SE0	full-speed idle: $V_{D+} > 2.7\text{ V}$ , $V_{D-} < 0.3\text{ V}$ ; SE0: $V_{D+} < 0.3\text{ V}$ , $V_{D-} < 0.3\text{ V}$	[4] -	-	500	$\mu\text{A}$
$I_{CC(I/O)(static)}$	static I/O supply current	full-speed idle, SE0 or suspend	-	-	20	$\mu\text{A}$
$I_{CC(susp)}$	suspend supply current	SUSPND = HIGH	[4] -	-	20	$\mu\text{A}$
$I_{CC(dis)}$	disable mode supply current	$V_{CC(I/O)}$ not connected	[4] -	-	20	$\mu\text{A}$
$I_{CC(I/O)(sharing)}$	sharing mode I/O supply current	$V_{CC(5.0)}$ or $V_{reg(3.3)}$ not connected	-	-	20	$\mu\text{A}$
$I_{Dx(sharing)}$	sharing mode load current on pins D+ and D-	$V_{CC(5.0)}$ or $V_{reg(3.3)}$ not connected; SOFTCON = LOW; $V_{Dx} = 3.6\text{ V}$	-	-	10	$\mu\text{A}$
$V_{reg(3.3)th}$	regulated supply voltage detection threshold	$1.65\text{ V} \leq V_{CC(I/O)} \leq V_{reg(3.3)}$ ; $2.7\text{ V} \leq V_{reg(3.3)} \leq 3.6\text{ V}$				
		supply lost	-	-	0.8	V
		supply present	[5] 2.4	-	-	V
$V_{reg(3.3)hys}$	regulated supply voltage detection hysteresis	$V_{CC(I/O)} = 1.8\text{ V}$	-	0.45	-	V
$V_{CC(I/O)th}$	I/O supply voltage detection threshold	$V_{reg(3.3)} = 2.7\text{ V to }3.6\text{ V}$				
		supply lost	-	-	0.5	V
		supply present	1.4	-	-	V
$V_{CC(I/O)hys}$	I/O supply voltage detection hysteresis	$V_{reg(3.3)} = 3.3\text{ V}$	-	0.45	-	V

[1]  $I_{load}$  includes the pull-up resistor current via pin  $V_{pu(3.3)}$ .

[2] In 'suspend' mode, the minimum voltage is 2.7 V.

[3] Maximum value is characterized only, not tested in production.

[4] Excluding any load current and  $V_{pu(3.3)}/V_{sw}$  source current to the 1.5 k $\Omega$  and 15 k $\Omega$  pull-up and pull-down resistors (200  $\mu\text{A}$  typ.).

[5] When  $V_{CC(I/O)} < 2.7\text{ V}$ , the minimum value for  $V_{th(reg(3.3)(present))}$  is 2.0 V.

**Table 14. Static characteristics: digital pins**

$V_{CC(I/O)} = 1.65\text{ V to }3.6\text{ V}$ ;  $V_{GND} = 0\text{ V}$ ;  $T_{amb} = -40\text{ }^{\circ}\text{C to }+85\text{ }^{\circ}\text{C}$ ; unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b><math>V_{CC(I/O)} = 1.65\text{ to }3.6\text{ V}</math></b>						
Input levels						
$V_{IL}$	LOW-level input voltage		-	-	$0.3V_{CC(I/O)}$	V
$V_{IH}$	HIGH-level input voltage		$0.6V_{CC(I/O)}$	-	-	V
Output levels						
$V_{OL}$	LOW-level output voltage	$I_{OL} = 100\text{ }\mu\text{A}$	-	-	0.15	V
		$I_{OL} = 2\text{ mA}$	-	-	0.4	V
$V_{OH}$	HIGH-level output voltage	$I_{OH} = 100\text{ }\mu\text{A}$	$V_{CC(I/O)} - 0.15$	-	-	V
		$I_{OH} = 2\text{ mA}$	$V_{CC(I/O)} - 0.4$	-	-	V
Leakage current						
$I_{LI}$	input leakage current		-1	-	+1	$\mu\text{A}$
<b>Example 1: <math>V_{CC(I/O)} = 1.8\text{ V} \pm 0.15\text{ V}</math></b>						
Input levels						
$V_{IL}$	LOW-level input voltage		-	-	0.5	V
$V_{IH}$	HIGH-level input voltage		1.2	-	-	V
Output levels						
$V_{OL}$	LOW-level output voltage	$I_{OL} = 100\text{ }\mu\text{A}$	-	-	0.15	V
		$I_{OL} = 2\text{ mA}$	-	-	0.4	V
$V_{OH}$	HIGH-level output voltage	$I_{OH} = 100\text{ }\mu\text{A}$	1.5	-	-	V
		$I_{OH} = 2\text{ mA}$	1.25	-	-	V
<b>Example 2: <math>V_{CC(I/O)} = 2.5\text{ V} \pm 0.2\text{ V}</math></b>						
Input levels						
$V_{IL}$	LOW-level input voltage		-	-	0.7	V
$V_{IH}$	HIGH-level input voltage		1.7	-	-	V
Output levels						
$V_{OL}$	LOW-level output voltage	$I_{OL} = 100\text{ }\mu\text{A}$	-	-	0.15	V
		$I_{OL} = 2\text{ mA}$	-	-	0.4	V
$V_{OH}$	HIGH-level output voltage	$I_{OH} = 100\text{ }\mu\text{A}$	2.15	-	-	V
		$I_{OH} = 2\text{ mA}$	1.9	-	-	V
<b>Example 3: <math>V_{CC(I/O)} = 3.3\text{ V} \pm 0.3\text{ V}</math></b>						
Input levels						
$V_{IL}$	LOW-level input voltage		-	-	0.9	V
$V_{IH}$	HIGH-level input voltage		2.15	-	-	V
Output levels						
$V_{OL}$	LOW-level output voltage	$I_{OL} = 100\text{ }\mu\text{A}$	-	-	0.15	V
		$I_{OL} = 2\text{ mA}$	-	-	0.4	V
$V_{OH}$	HIGH-level output voltage	$I_{OH} = 100\text{ }\mu\text{A}$	2.85	-	-	V
		$I_{OH} = 2\text{ mA}$	2.6	-	-	V
Capacitance						
$C_{IN}$	input capacitance	pin to GND	-	-	10	pF

**Table 15. Static characteristics: analog I/O pins (D+, D-)**

$V_{CC} = 4.0\text{ V to }5.5\text{ V}$  or  $V_{reg(3.3)} = 3.0\text{ V to }3.6\text{ V}$ ;  $V_{GND} = 0\text{ V}$ ;  $T_{amb} = -40\text{ }^{\circ}\text{C to }+85\text{ }^{\circ}\text{C}$ ; unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>Input levels</b>						
<b>Differential receiver</b>						
$V_{DI}$	differential input sensitivity	$ V_{I(D+)} - V_{I(D-)} $	0.2	-	-	V
$V_{CM}$	differential common mode voltage	includes $V_{DI}$ range	0.8	-	2.5	V
<b>Single-ended receiver</b>						
$V_{IL}$	LOW-level input voltage		-	-	0.8	V
$V_{IH}$	HIGH-level input voltage		2.0	-	-	V
$V_{hys}$	hysteresis voltage		0.4	-	0.7	V
<b>Output levels</b>						
$V_{OL}$	LOW-level output voltage	$R_L = 1.5\text{ k}\Omega$ to +3.6 V	-	-	0.3	V
$V_{OH}$	HIGH-level output voltage	$R_L = 15\text{ k}\Omega$ to GND	[1] 2.8	-	3.6	V
<b>Leakage current</b>						
$I_{LZ}$	OFF-state leakage current		-1	-	+1	$\mu\text{A}$
<b>Capacitance</b>						
$C_{IN}$	transceiver capacitance	pin to GND	-	-	20	pF
<b>Resistance</b>						
$Z_{DRV}$	driver output impedance	steady-state drive	[2] 34	39	44	$\Omega$
$Z_{INP}$	input impedance		10	-	-	$\text{M}\Omega$
$R_{SW}$	internal switch resistance at pin $V_{pu(3.3)}$		-	-	10	$\Omega$
<b>Termination</b>						
$V_{TERM}$	termination voltage for upstream port pull-up ( $R_{PU}$ )		[3][4] 3.0	-	3.6	V

[1]  $V_{OH(\min)} = V_{reg(3.3)} - 0.2\text{ V}$ .

[2] Includes external resistors of  $33\ \Omega \pm 1\%$  on both D+ and D-.

[3] This voltage is available at pins  $V_{reg(3.3)}$  and  $V_{pu(3.3)}$ .

[4] In 'suspend' mode the minimum voltage is 2.7 V.

## 12. Dynamic characteristics

**Table 16. Dynamic characteristics: analog I/O pins (D+, D-)**

$V_{CC} = 4.0\text{ V to }5.5\text{ V}$  or  $V_{reg(3.3)} = 3.0\text{ V to }3.6\text{ V}$ ;  $V_{CC(I/O)} = 1.65\text{ V to }3.6\text{ V}$ ;  $V_{GND} = 0\text{ V}$ ; see [Table 10](#) for valid voltage level combinations;  $T_{amb} = -40\text{ }^{\circ}\text{C to }+85\text{ }^{\circ}\text{C}$ ; unless otherwise specified.<sup>[1]</sup>

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>Driver characteristics</b>						
<b>Full-speed mode</b>						
$t_{FR}$	rise time	$C_L = 50\text{ pF to }125\text{ pF}$ ; 10 % to 90 % of $ V_{OH} - V_{OL} $ ; see <a href="#">Figure 7</a>	4	-	20	ns
$t_{FF}$	fall time	$C_L = 50\text{ pF to }125\text{ pF}$ ; 90 % to 10 % of $ V_{OH} - V_{OL} $ ; see <a href="#">Figure 7</a>	4	-	20	ns
FRFM	differential rise/fall time matching ( $t_{FR}/t_{FF}$ )	excluding the first transition from idle state	90	-	111.1	%
$V_{CRS}$	output signal crossover voltage	excluding the first transition from idle state; see <a href="#">Figure 10</a>	[2] 1.3	-	2.0	V
<b>Low-speed mode</b>						
$t_{LR}$	rise time	$C_L = 50\text{ pF to }600\text{ pF}$ ; 10 % to 90 % of $ V_{OH} - V_{OL} $ ; see <a href="#">Figure 7</a>	75	-	300	ns
$t_{LF}$	fall time	$C_L = 50\text{ pF to }600\text{ pF}$ ; 90 % to 10 % of $ V_{OH} - V_{OL} $ ; see <a href="#">Figure 7</a>	75	-	300	ns
LRFM	differential rise/fall time matching ( $t_{LR}/t_{LF}$ )	excluding the first transition from idle state	80	-	125	%
$V_{CRS}$	output signal crossover voltage	excluding the first transition from idle state; see <a href="#">Figure 10</a>	[2] 1.3	-	2.0	V
<b>Driver timing</b>						
<b>Full-speed mode</b>						
$t_{PLH(drv)}$	driver propagation delay ( $V_O/V_{PO}$ , FSE0/VMO to D+,D-)	LOW-to-HIGH; see <a href="#">Figure 10</a>	-	-	18	ns
$t_{PHL(drv)}$	driver propagation delay ( $V_O/V_{PO}$ , FSE0/VMO to D+,D-)	HIGH-to-LOW; see <a href="#">Figure 10</a>	-	-	18	ns
$t_{PHZ}$	driver disable delay ( $\overline{OE}$ to D+,D-)	HIGH-to-OFF; see <a href="#">Figure 8</a>	-	-	15	ns
$t_{PLZ}$	driver disable delay ( $\overline{OE}$ to D+,D-)	LOW-to-OFF; see <a href="#">Figure 8</a>	-	-	15	ns
$t_{PZH}$	driver enable delay ( $\overline{OE}$ to D+,D-)	OFF-to-HIGH; see <a href="#">Figure 8</a>	-	-	15	ns
$t_{PZL}$	driver enable delay ( $\overline{OE}$ to D+,D-)	OFF-to-LOW; see <a href="#">Figure 8</a>	-	-	15	ns
<b>Low-speed mode</b>						

**Not specified:** low-speed delay timings are dominated by the slow rise/fall times  $t_{LR}$  and  $t_{LF}$ .

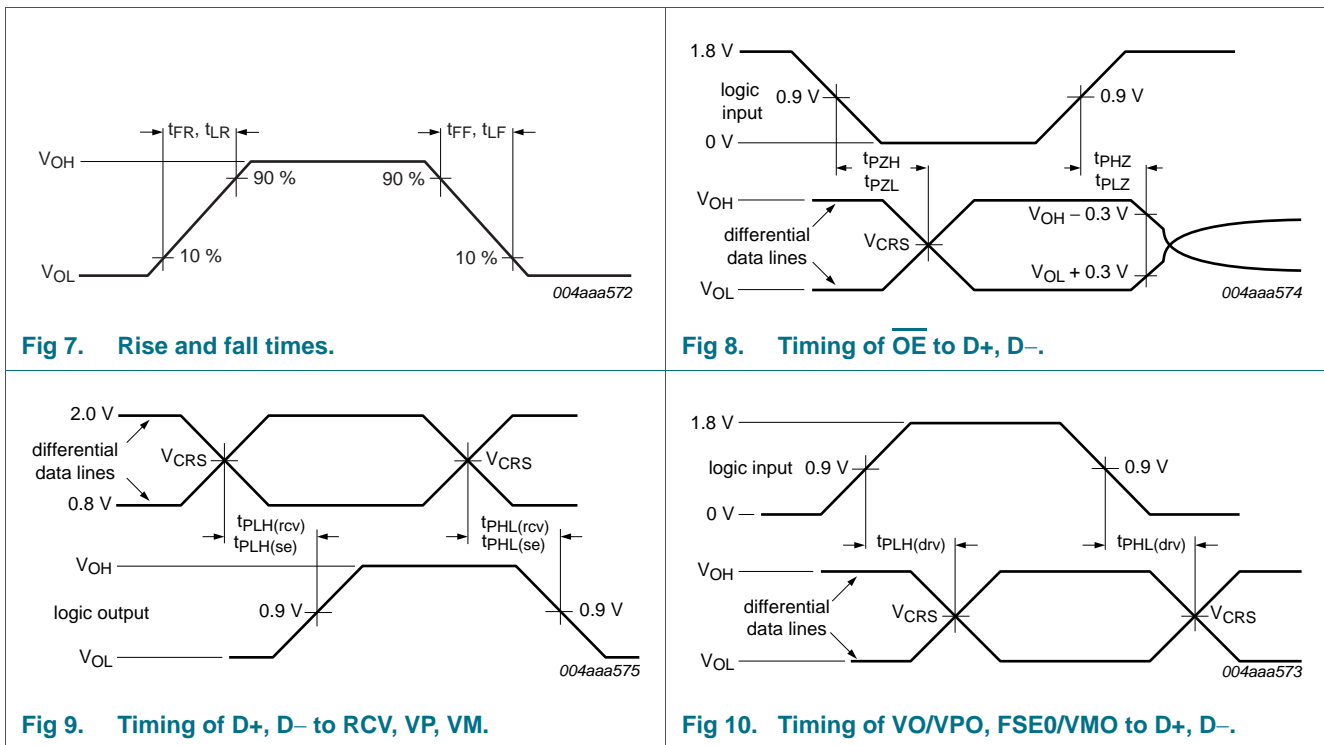
**Table 16. Dynamic characteristics: analog I/O pins (D+, D-) ...continued**

$V_{CC} = 4.0\text{ V to }5.5\text{ V}$  or  $V_{reg(3.3)} = 3.0\text{ V to }3.6\text{ V}$ ;  $V_{CC(I/O)} = 1.65\text{ V to }3.6\text{ V}$ ;  $V_{GND} = 0\text{ V}$ ; see [Table 10](#) for valid voltage level combinations;  $T_{amb} = -40\text{ }^{\circ}\text{C to }+85\text{ }^{\circ}\text{C}$ ; unless otherwise specified.[1]

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>Receiver timings (full-speed and low-speed mode)</b>						
<b>Differential receiver</b>						
$t_{PLH(rcv)}$	propagation delay (D+,D- to RCV)	LOW-to-HIGH; see <a href="#">Figure 9</a>	-	-	15	ns
$t_{PHL(rcv)}$	propagation delay (D+,D- to RCV)	HIGH-to-LOW; see <a href="#">Figure 9</a>	-	-	15	ns
<b>Single-ended receiver</b>						
$t_{PLH(se)}$	propagation delay (D+,D- to VP, VM)	LOW-to-HIGH; see <a href="#">Figure 9</a>	-	-	18	ns
$t_{PHL(se)}$	propagation delay (D+,D- to VP, VM)	HIGH-to-LOW; see <a href="#">Figure 9</a>	-	-	18	ns

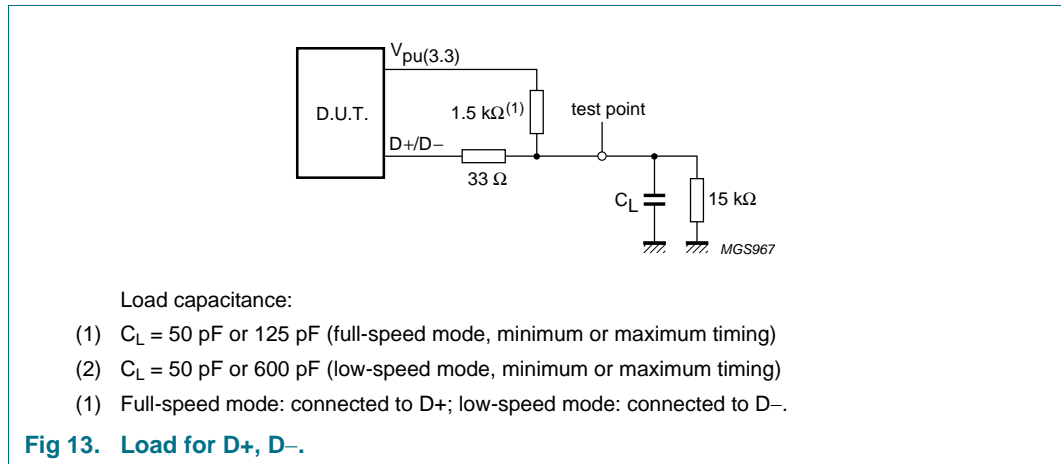
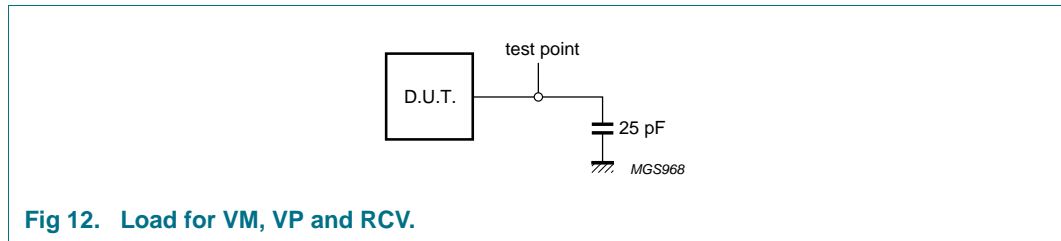
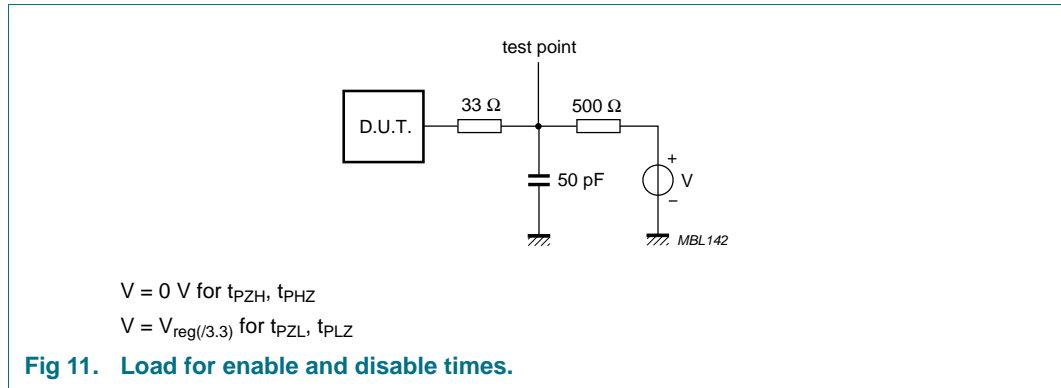
[1] Test circuit: see [Figure 13](#).

[2] Characterized only, not tested. Limits guaranteed by design.





## 13. Test information



## 14. Package outline

HBCC16: plastic thermal enhanced bottom chip carrier; 16 terminals; body 3 x 3 x 0.65 mm

SOT639-2

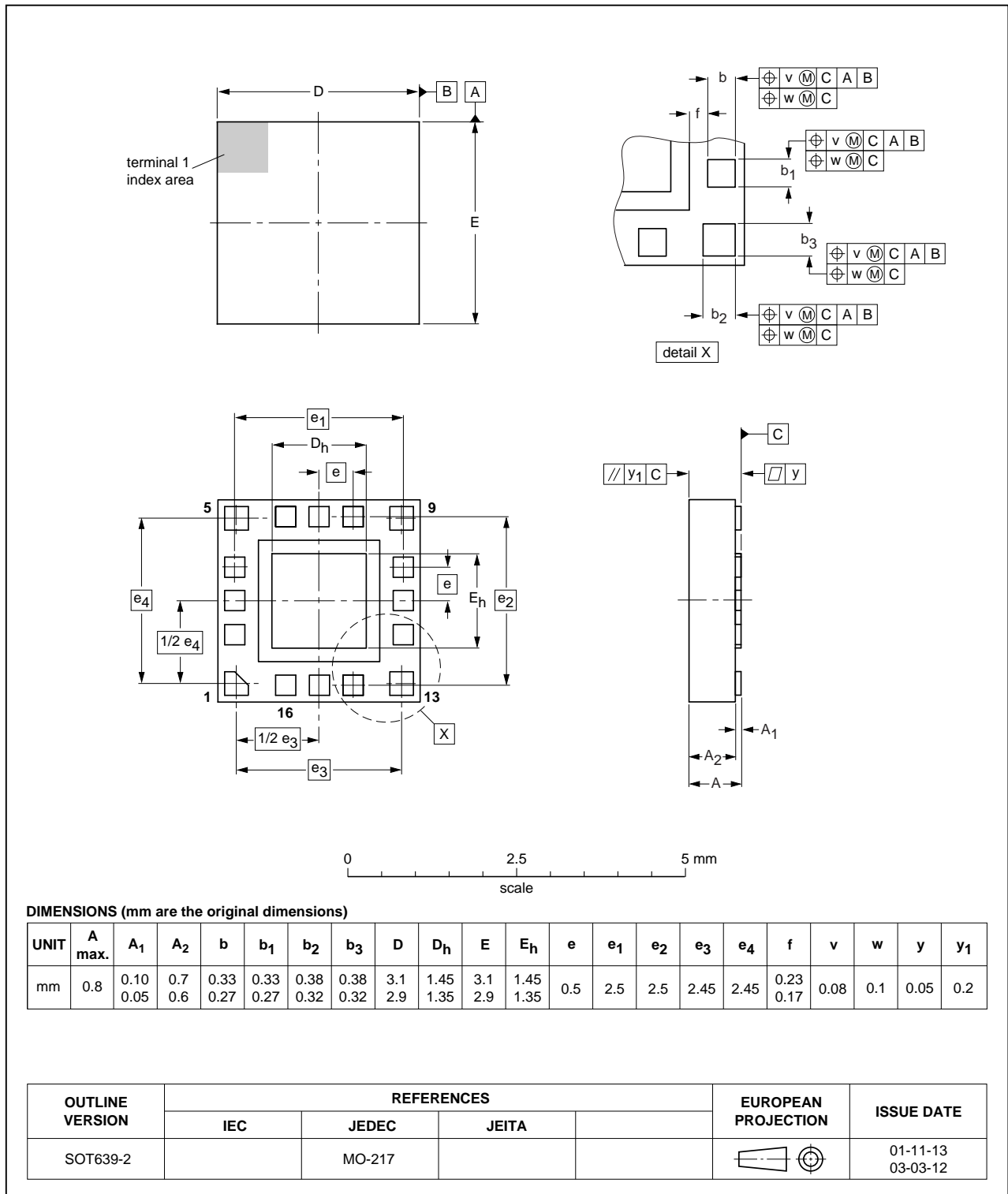


Fig 14. HBCC16 package outline.

HVQFN16: plastic thermal enhanced very thin quad flat package; no leads; 16 terminals; body 3 x 3 x 0.85 mm

SOT758-1

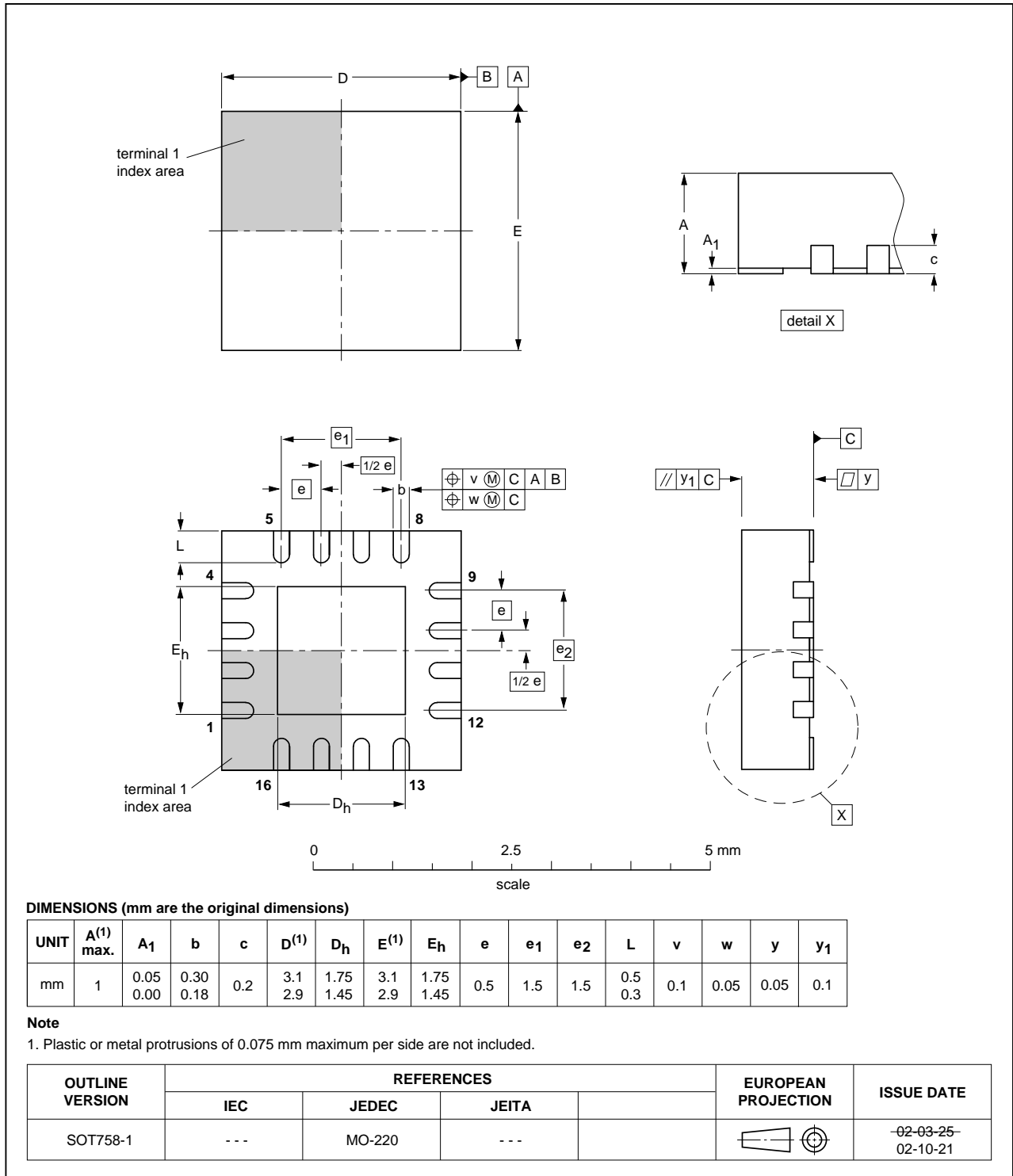


Fig 15. HVQFN16 package outline.

TSSOP16: plastic thin shrink small outline package; 16 leads; body width 4.4 mm

SOT403-1

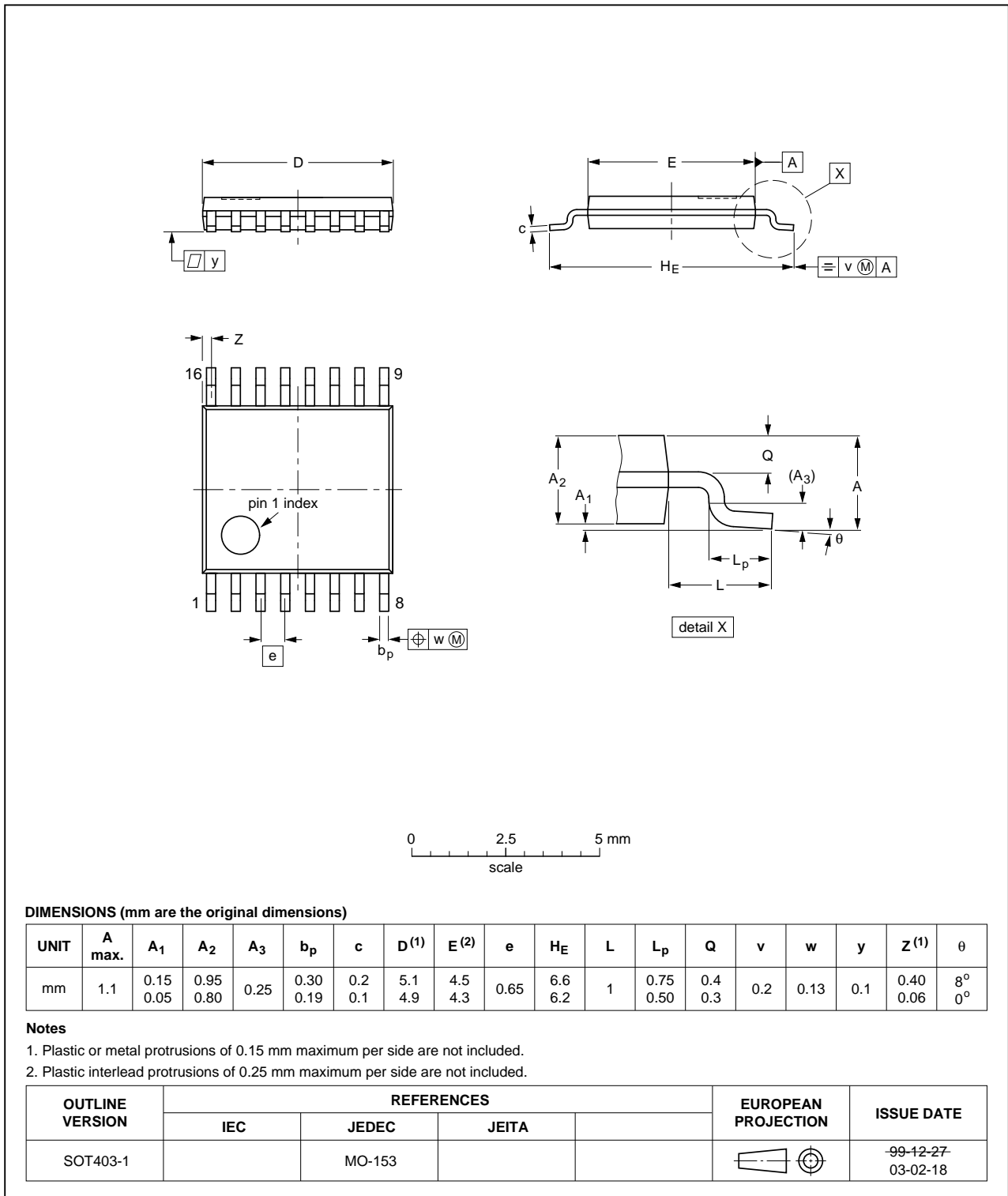


Fig 16. TSSOP16 package outline.

## 15. Revision history

**Table 17. Revision history**

Document ID	Release date	Data sheet status	Change notice	Supersedes
ISP1105_1106_10	20090928	Product data sheet	-	ISP1105_1106_9
Modifications:	<ul style="list-style-type: none"> <li>• Rebranded to the ST-Ericsson template.</li> <li>• <a href="#">Section 2 "Features"</a>: updated.</li> <li>• <a href="#">Section 4 "Ordering information"</a>: updated.</li> <li>• Removed packing information.</li> <li>• Removed soldering information.</li> </ul>			
ISP1105_1106_9	20090119	Product data sheet	-	ISP1105_1106-08
ISP1105_1106-08 (9397 750 09529)	20040219	Product data	-	ISP1105_1106_1107-07
ISP1105_1106_1107-07 (9397 750 08872)	20020329	Product data	-	ISP1105_1106_1107-06
ISP1105_1106_1107-06 (9397 750 08681)	20011130	Product data	-	ISP1105_1106_1107-05
ISP1105_1106_1107-05 (9397 750 08643)	20010903	Product data	-	ISP1105_1106_1107-04
ISP1105_1106_1107-04 (9397 750 08515)	20010802	Preliminary data	-	ISP1105_1106_1107-03
ISP1105_1106_1107-03 (9397 750 07879)	20010704	Preliminary data	-	ISP1107-02
ISP1107-02 (9397 750 06899)	20010205	Objective specification; ISP1107 stand-alone data sheet only	-	ISP1107-01
ISP1107-01 (9397 750 08643)	20000223	Objective specification; ISP1107 stand-alone data sheet only	--	-

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